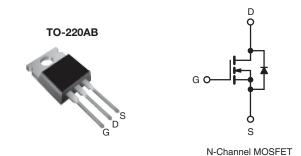


## Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	60				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 5.0 V 0.028				
Q <sub>g</sub> (Max.) (nC)	66				
Q <sub>gs</sub> (nC)	12				
Q <sub>gd</sub> (nC)	43				
Configuration	Single				



### **FEATURES**

- Dynamic dV/dt Rating
- · Logic-Level Gate Drive
- R<sub>DS(on)</sub> Specified at V<sub>GS</sub> = 4 V and 5 V
- 175 °C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Load (Dh) fros	IRLZ44PbF
Lead (Pb)-free	SiHLZ44-E3
SnPb	IRLZ44
SIFD	SiHLZ44

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	60	.,	
Gate-Source Voltage			$V_{GS}$	± 10	V	
Continuous Drain Currente	V <sub>GS</sub> at 5.0 V	$T_C = 25 ^{\circ}C$		50		
Continuous Drain Current	VGS at 5.0 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	36	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	200		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	$P_{D}$	150	W	
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s			300	]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 179  $\mu$ H,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 51 A (see fig. 12). c.  $I_{SD} \le 51$  A,  $dV/dt \le 250$  A/s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175$  °C.
- d. 1.6 mm from case.
- e. Current limited by the package, (die current = 51 A).

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	62		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	1.0		

PARAMETER	SYMBOL	TEST (	MIN.	TYP.	MAX.	UNIT		
Static		1			·		ı	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0	V, I <sub>D</sub> = 250 μA	60	_	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I <sub>D</sub> = 1 mA	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{c}$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	1.0	-	2.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	Vo	V <sub>GS</sub> = 10 V		-	± 100	nA	
Zana Cata Valtana Busin Courset	I <sub>DSS</sub>	$V_{DS} = 6$	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V		-	25		
Zero Gate Voltage Drain Current		$V_{DS} = 48 \text{ V}, V_{0}$	V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C		-	250	μA	
Duein Course On Otata Basistana	Б	V <sub>GS</sub> = 5.0 V	I <sub>D</sub> = 31 A <sup>b</sup>	-	-	0.028		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.0 V	I <sub>D</sub> = 25 A <sup>b</sup>	-	-	0.039	Ω	
Forward Transconductance	9fs	V <sub>DS</sub> = 2	5 V, I <sub>D</sub> = 31 A <sup>b</sup>	23	-	-	S	
Dynamic								
Input Capacitance	C <sub>iss</sub>	V	$V_{GS} = 0 V$ ,		3300	-		
Output Capacitance	C <sub>oss</sub>	V <sub>C</sub>	$_{0S} = 25 \text{ V},$	-	1200	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	200	-	1	
Total Gate Charge	$Q_g$			-	-	66	nC	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5.0 V	$I_D = 51 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	=	-	12		
Gate-Drain Charge	$Q_{gd}$	See lig. 0 and 10		-	-	43	1	
Turn-On Delay Time	t <sub>d(on)</sub>			-	17	-		
Rise Time	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, I_D = 51 \text{ A}, \\ R_g = 4.6 \ \Omega, R_D = 0.56 \ \Omega, \text{ see fig. } 10^b$		-	230	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	42	-		
Fall Time	t <sub>f</sub>				110	-		
Internal Drain Inductance	$L_{D}$	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	111	
<b>Drain-Source Body Diode Characteristic</b>	s							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50°	Α	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	200		
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 51 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	2.5	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 51 A, dl/dt = 100 A/μs <sup>b</sup>		-	130	180	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.84	1.3	μC	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-	-on is do	minated b	y L <sub>S</sub> and	L <sub>D</sub> )		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.
- c. Current limited by the package, (die current = 51 A).



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

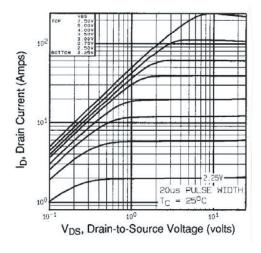


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

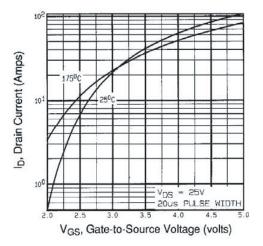


Fig. 3 - Typical Transfer Characteristics

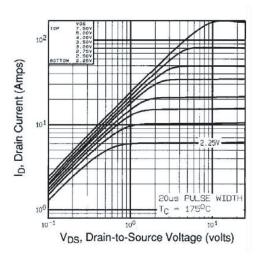


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 175 °C

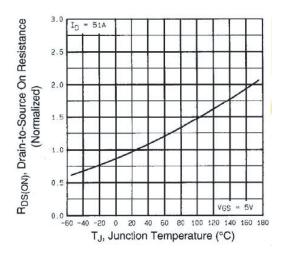


Fig. 4 - Normalized On-Resistance vs. Temperature



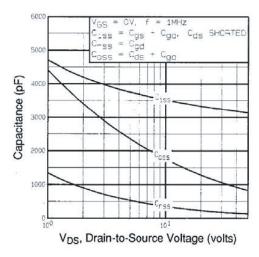


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

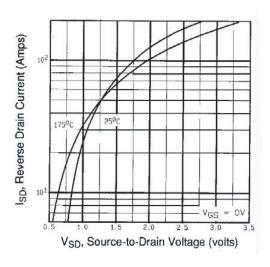


Fig. 7 - Typical Source-Drain Diode Forward Voltage

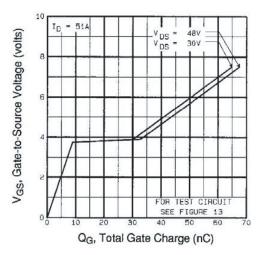


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

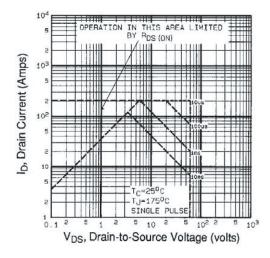


Fig. 8 - Maximum Safe Operating Area





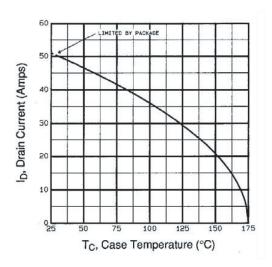


Fig. 9 - Maximum Drain Current vs. Case Temperature

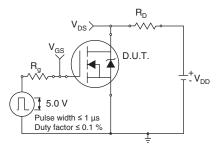


Fig. 10a - Switching Time Test Circuit

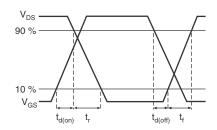


Fig. 10b - Switching Time Waveforms

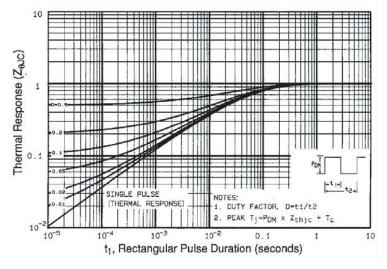
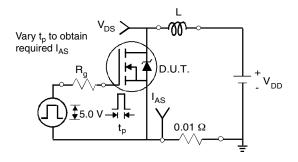


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





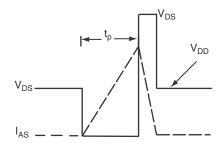


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

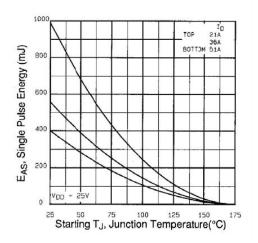


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

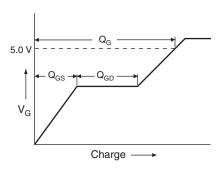


Fig. 13a - Basic Gate Charge Waveform

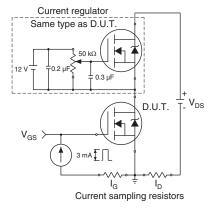
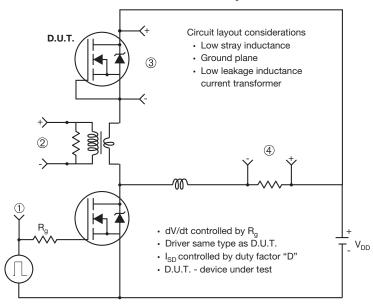


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit



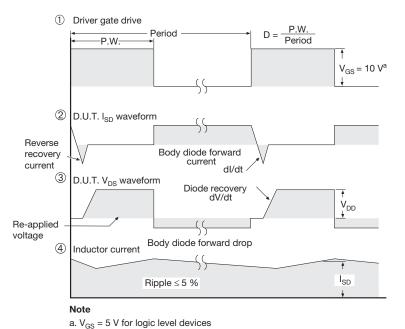


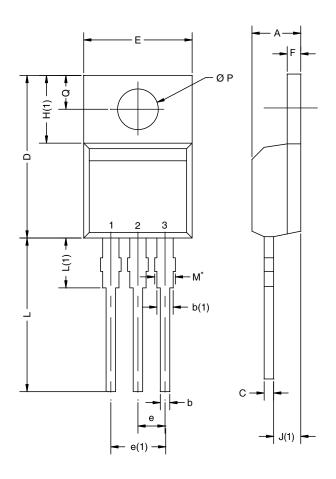
Fig. 14 - For N-Channel

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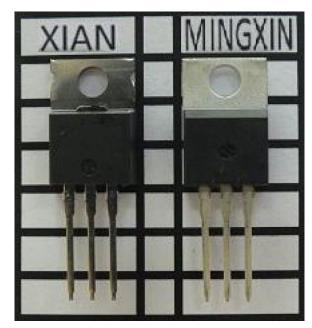
## **TO-220AB**



	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
E	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØР	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471						

#### **Notes**

- $^{\star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM
- Xi'an and Mingxin actual photo





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Vishay

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